Notice of References Cited

Application/Control No. 10/722,934	Applicant(s)/Patent Under Reexamination LANE ET AL.		
Examiner	Art Unit		
Alexander O Williams	2826	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0197856 A1	12-2002	Matsuse et al.	438/652
	В	US-2002/0102826 A1	08-2002	Shimamoto et al.	438/575
	С	US-6,740,252 B2	05-2004	Kraus et al.	252/79.1
	D	US-2002/0036348 A1	03-2002	Matsunaga et al.	257/758
	E.	US-2002/0123235 A1	09-2002	Kraus et al.	438/755
	F	US-5,637,533	06-1997	Choi, Kyeong K.	438/643
	G	US-2004/0113279 A1	06-2004	Chen et al.	257/774
	Н	US-2004/0152255 A1	08-2004	Seidl et al.	438/240
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	:				
	0				V - 100 T - 10	
	Р					
	O					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.